

**Electrostatic discharge (ESD) sensitivity  
testing human body model (HBM)**

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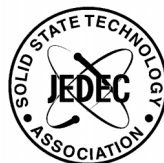
IEC/PAS 62179:2000

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**PUBLICLY AVAILABLE SPECIFICATION**



INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION



Reference number  
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# EIA/JEDEC STANDARD

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## Test Method A114-A

### Electrostatic Discharge (ESD) Sensitivity Testing Human Body Model (HBM)

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## EIA/JESD22-A114-A

(Revision of EIA/JESD22-A114)

OCTOBER 1997

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ELECTRONIC INDUSTRIES ASSOCIATION

ENGINEERING DEPARTMENT



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## INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROSTATIC DISCHARGE (ESD) SENSITIVITY  
TESTING HUMAN BODY MODEL (HBM)

## FOREWORD

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IEC-PAS 62179 was submitted by JEDEC and has been processed by IEC technical committee 47: Semiconductor devices.

The text of this PAS is based on the following document:

This PAS was approved for publication by the P-members of the committee concerned as indicated in the following document:

Draft PAS	Report on voting
47/1452/PAS	47/1485/RVD

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